

## (54) PUNCHING-OUT/TAKING-OUT DEVICE FOR TESTPIECE

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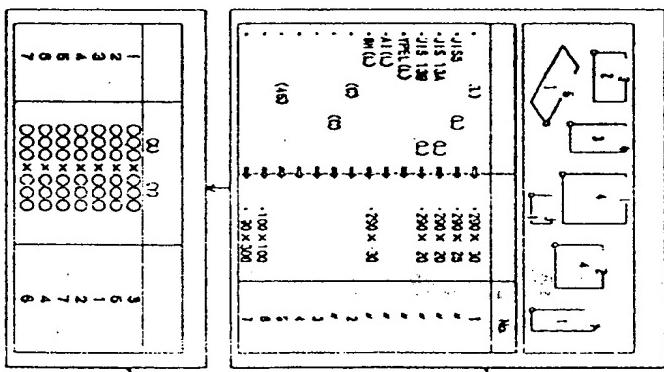
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**PURPOSE:** To automatically take out a testpiece efficiently from a sample member.

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**CONSTITUTION:** A punching-out taking-out device for a testpiece takes out the testpiece from a sample member under the control by an NC controller controlled by an upper rank calculator, and is equipped with a means which specifies the taking-out enabled region for the testpiece which is to be taken out on the basis of the order specification by the upper rank calculator (Step 101, 102), and a means which determines the punching-out coordinates and the punching out order of each testpiece by an NC controller on the basis of the above-described result, kind of the testpiece, size and the standard coordinates which are previously set (Step 103).

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	1	2	3	4
1	000x000	000x000	000x000	000x000
2	000x000	000x000	000x000	000x000
3	000x000	000x000	000x000	000x000
4	000x000	000x000	000x000	000x000
5	000x000	000x000	000x000	000x000
6	000x000	000x000	000x000	000x000
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**LEGENDE zu den Bibliographiedaten**

(54) Titel der Patentanmeldung

(22) Anmeldetag in Japan

(11) Nummer der JP-A2 Veröffentlichung

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(21) Aktenzeichen der JP-Anmeldung

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